

Notice of References Cited	Application/Control No. 10/532,084	Applicant(s)/Patent Under Reexamination YASUMURA ET AL.	
	Examiner Ives Wu	Art Unit 1724	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0055030 A1	05-2002	Okumura et al.	429/34
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	JP 03-199230	08-1991	Japan	Toshiro et al	C08G 64/02
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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